TESTING A SOFTWARE-BASED PID CONTROLLER USING METAMORPHIC TESTING

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Abstract: The Proportional-Integral-Derivative (PID) controller is ubiquitous in industrial and military systems. Almost all PID controllers are now implemented as software in a microcontroller. Control systems are required to have very high reliability, particularly as they are regularly used in safety-critical systems. An effective testing technique is essential to achieve reliable PID controller software. Unlike simple control algorithms, PID controllers are capable of manipulating the process inputs based on the history and rate of change of the signal. It is very difficult to know whether the computation of the software is correct from the computed outputs. Previous research in other areas has shown that metamorphic testing is an effective technique for this kind of problem. In this paper, we examine metamorphic testing in the context of testing an embedded software PID controller based on the free sample code from ATMEL Corporation. We show that metamorphic testing killed all mutants inserted into the controller software, demonstrating the utility of the technique in testing control systems.

1 INTRODUCTION

Control engineering, the application of control theory to engineering, is widely applied in many industrial and military systems. The main purpose of control is to aid the product or process to do its job efficiently to a required specification. A controller is a device which receives monitoring signals and outputs control signals that affect the operational conditions of a given dynamical system. The operational conditions are the output variables of the system which can be affected by adjusting certain input variables.

For example, consider a radar tracking antenna (as described in Nise (2008)), in which the antenna dish is driven through a step down gearbox by an armature controlled D.C. motor as shown in Fig. 1. The antenna azimuth position is monitored by a precision potentiometer, the output of which is then compared with demand signal provided by the radar system. The error signal – the difference between the desired position and the measured antenna azimuth position - is amplified to drive the motor so that the antenna follows the target motion. In this example, the amplifiers act as the controller, directing the activities of the D.C. motor. The D.C. motor is the processor that affects the antenna position to follow the target position (also known as the set point). The antenna azimuth position information from the potentiometer is the feedback. The antenna position is the operational condition.

Control systems are ubiquitous, and many control systems are applied in safety-critical systems and thus face very high reliability requirements. Control systems are broadly classified as open-loop and closed-loop control system. An open-loop control system is controlled directly, and only, by an input

Figure 1: Radar tracking antenna.
signal, without any feedback from outputs. The systems that utilize feedback are called closed-loop control systems. The feedback is used to make decision about changes to the control signal that drives the plant (in the case of our example, the antenna). It is well known that the deliberate use of feedback can be used to stabilize an otherwise unstable system, to reduce errors due to input disturbance and to reduce the sensitivity of the system performance to changes in parameter values caused by temperature, aging of hardware, etc. Hence, most control systems are of the closed-loop type. Many different control algorithms have historically been used in control systems, but Proportional-Integral-Derivative (PID) control (Kuo, 1982) is the most common control algorithm used in industry and has been universally accepted in industrial control. The popularity of PID controllers can be attributed partly to their robust performance in a wide range of operating conditions and partly to their functional simplicity, which allows engineers to configure them in a simple, straightforward manner. With the ubiquity of microcontroller technology, PID controllers are typically implemented by the embedded software in a microcontroller.

As PID controllers are used in most control systems, it is important to ensure the reliability of PID software. Software testing is the primary way in which the reliability of software is assessed and improved, and, therefore, effective testing of PID software is the critical step for a reliable control system. Testing PID software is a challenging task. Unlike simple control algorithms, the PID controller is capable of manipulating the process inputs based on the history and rate of change of the error signal. This gives a more accurate and stable control method but complicates the testing process. As the output can vary because of the history and rate of change of the error signal, it is very difficult to check the correctness of PID implementation from its outputs. This is known as the oracle problem in software testing. Recently, the technique of metamorphic testing has been proposed for testing software without the need of an oracle (Chan, Chen, Lu, Tse & Yao (2006); Chen, Cheung & Yu (1998); Chen, Tse & Zhou (2002); Zhou, Huang, Tse, Yang, Huang & Chen (2004)). This technique identifies some necessary properties of the application domain as metamorphic relations (MRs), that (as discussed in Section 2) express relationships between multiple executions, with different inputs, of the software under test. In metamorphic testing, testers check the MRs among multiple executions of the program being tested – if the MRs do not hold, this indicates a software fault.

In this paper, we study the application of metamorphic testing to alleviate the oracle problem of testing PID controller software. We present a case study on the testing of the PID controller software embedded in an ATMEG Atmega128 microcontroller. The PID controller software was implemented in C based on the free sample code provided by ATMEG Corporation (Atmel Corporation, 2006). To verify the effectiveness of using metamorphic testing in the embedded software for control engineering, we conducted our experiments in the control of antenna azimuth position. Instead of building the actual antenna azimuth position control system, we simulated the system in the embedded platform using Z-transform. This approach eliminates the measurement error in the mechanical position measurement and avoids hardware faults interfering with the testing of the PID controller software.

The rest of the paper is organized as follows. In Section 2 we briefly present the technique of metamorphic testing. Section 3 presents the basic design of the PID controller. In Section 4, we identify four MRs for PID controllers. We then apply the technique of metamorphic testing to test the software of a PID controller. Section 5 briefly analyzes threats to validity. Section 6 concludes our paper by considering the implications of the work and identifying opportunities for future research. Detailed justification of the MRs are provided in the Appendix.

![Figure 2: Feedback control system.](image)

2 METAMORPHIC TESTING

Metamorphic testing (Chen, Cheung & Yiu, 1998) is a property-based approach to software testing. It does not check the correctness of individual outputs. Instead, it checks metamorphic relations among multiple executions of the target program. A metamorphic relation (MR) is an expected relation, which is identified from the necessary properties of application domain, over a set of distinct input data.
and their corresponding output values for multiple executions of the target program. In theory, a program should satisfy all the necessary properties if implemented correctly. Any program which violates the MRs contains faults.

Let us consider a function \( f \). Suppose \( R_f \) denotes some properties of \( f \) that can be expressed as a relation among a series of the function’s inputs \( x_1, x_2, \ldots, x_n \), where \( n > 1 \), and their corresponding values \( f(x_1), f(x_2), \ldots, f(x_n) \). The relation \( R_f \) is called a metamorphic relation. For instance, consider the sine function. For any two inputs \( x_1 \) and \( x_2 \) such that \( x_1 + x_2 = \pi \), we must have \( \sin(x_1) = \sin(x_2) \). This property can be a metamorphic relation for testing the correctness of the sine function. It can be written as

\[
R_{\sin}: \text{If } x_1 + x_2 = \pi, \text{ then } \sin(x_1) = \sin(x_2).
\]

To verify this relation, two executions are needed. The first input to \( \sin \) function is a real number \( x_1 \), followed by a second input \( x_2 = \pi - x_1 \).

In summary, even if a testing oracle does not exist, metamorphic testing can still be applied as it checks the relations among the inputs and outputs of more than one execution of the program.

3 PID CONTROLLER

As discussed in Section 1, a control system is a device that monitors and affects the operational conditions of a given dynamical system.

A generalized block diagram for a feedback control loop is shown in Fig. 2. The plant process is the process or device that acts on the system; in the context of the radar antenna it is the DC control motor. The feedback transducer, in turn, measures the current state of the system under control – for the antenna system, the potentiometer position sensor. The role of the controller is therefore to:

(a) enable the desired value of output to be set;
(b) accept the measured output value from the feedback transducer,
(c) generate the error (deviation between desired and present output) signal,
(d) amplify and process the error signal to provide a suitable input to the final control element.

![Figure 3: Block diagram of general PID control system.](image)

The PID controller is the most common solution because of its simplicity of implementation and good performance. Fig. 3 shows the block diagram of a general PID control system. As can be seen, the output value at time \( t \), \( u(t) \) of a PID controller is governed by the following equation (Atmel Corporation, 2006):

\[
u(t) = K_I \left( e(t) + \frac{1}{T_i} \int_0^t e(\sigma) d\sigma + T_d \frac{de(t)}{dt} \right)\tag{1}\]

This can be easily considered as the sum of three terms, governed by three key parameters: the proportional parameter \( K_p \), the integral parameter \( K_i \), and the derivative parameter \( K_d \). The integral and derivative terms can also be equivalently expressed as “action times” \( T_i \) and \( T_d \) respectively. The three terms are as follows:

- **Proportional term**: \( K_p \times e(t) \)
- **Integral term**: \( \frac{K_i}{T_i} \times \int e(\sigma) d\sigma = K_i \times \int e(\sigma) d\sigma \)
- **Derivative term**: \( K_d \times T_d \times \frac{de(t)}{dt} = K_d \times \frac{de(t)}{dt} \)

In control theory, a continuous control system is usually represented by a Laplace transformed s-transfer function. The s-transfer function of PID controller can be expressed as follows:

\[
u(s) = K_p \left[ 1 + \frac{1}{sT_i} + sT_d \right] E(s)
\]

where \( u(s) \) is the Laplace transform of the controller output \( u(t) \) and \( E(s) \) is the Laplace transform of error signal \( e(t) \).

Not all controllers necessarily make use of all three terms in the PID control formula. While all controllers use some level of proportional control (and thus have a non-zero \( K_p \)), in different applications the integral and derivative terms may or may not be used.

P control, on its own, is the simplest form of control. If the parameter \( K_p \) is increased, it reduces the errors inherent in the system. The maximum value of \( K_p \) is limited due to the onset of instability (that is, the controller failing to reach a steady state). PI control, involving both the proportional and integral terms, can reduce the steady-state error (the difference between the actual final state and the desired final state). PD control, involving both proportional and derivative terms is used to improve the dynamic performance of the loop, to improve
stability and speed up the time response. PID control combines all three forms of control. It can eliminate the steady-state error and improve the dynamic performance.

Digital controllers are widely available at low cost and are consequently in widespread use. These range from small inexpensive single board controllers having a limited amount of input/output facilities and memory, and a small high level language instruction set, to powerful microcomputers or programmable logic controller (PLC) capable of controlling many control loops. There are many advantages in using digital controllers, including:

- The possibility of a wide range of control algorithms.
- The ability to change algorithm parameter values easily by software without modifying any hardware.
- The ability to make the system adaptive.
- The ability to compensate for process non-linearity by non-linear control algorithms.
- The ease of implementing arithmetic operations.

Unlike analogue controllers, digital controllers use discrete, periodic sampling from the feedback transducer. It is important for the intervals between sampling to be small enough – or, in other words, the sample frequency to be high enough - so that the sampled points represent the continuous signal accurately enough. If the maximum frequency presents in the signal is $\omega$, the theoretical minimum sampling frequency should be $2\omega$ (Nyquist, 1928).

Consider a control system as shown in Fig. 3, the PID controller is a digital controller implemented by the embedded software in a microcontroller. At time $t$, the digital PID controller will read the error $e(t)$, calculate and output the control input $u(t)$ to the system. The process repeats at intervals defined by the sample period $T$. At time $t$, $n = t/T$ such cycles have occurred; in other words, $t = nT$.

When implementing a software-based digital PID controller, the continuous integrals are approximated using summations. The integral term is approximated as follows:

$$\int_0^e(s)ds = \sum_{k=0}^n e(k)$$

The derivative term is approximated by the following equation:

$$\frac{de(t)}{dt} \approx \frac{e(n) - e(n-1)}{T}$$

This gives the controller:

$$u(n) = K_p e(n) + K_i \sum_{k=0}^n e(k) + K_d (e(n) - e(n-1)) \quad (2)$$

where $K_i = \frac{K_p}{T}$ and $K_d = \frac{K_p}{T_d}$.

Figure 4: Block diagram of antenna azimuth position system with PID control.

Most software PID controllers are implemented based on formula (2).

### 4 TESTING PID SOFTWARE USING METAMORPHIC TESTING

#### 4.1 Experimental Subject

The PID controller software being tested is based on the sample code revision 456 dated 16 Feb. 2006 provided by ATMEL Corporation (Atmel Corporation, 2006). The code comprised 478 lines of C code, and was compiled using the IAR EWAAVR 4.11A compiler for the ATMEL AVR microcontrollers. In our experiment, we chose the AVR ATMega128 microcontroller to run the PID software.

#### 4.2 Experimental Setup

We used an antenna azimuth position system, as shown in Fig. 4, in our experiment. The process plant in the block diagram is a mechanical system with D.C. motor, gear and potentiometer.

Instead of using a real antenna azimuth position system, we simulated the antenna azimuth position system in the embedded platform. The behavior of the system is described using $z$-transfer functions (Kuo (2006), p51). The block diagram of the experimental system is shown in Fig. 5. Aside from the obvious convenience of not requiring an actual radar antenna system for our experiments, there are many advantages of using a simulation platform to replace the actual system:
• Hardware problems in antenna azimuth position system are eliminated when testing the PID controller software.
• The system outputs are monitored easily to verify the performance of the PID controller without using expensive testing equipment.
• The system parameters can be varied easily.
• A wide range of test cases can be selected in the simulation platform without the need to consider hardware limitations.

![Figure 5: Block diagram of antenna azimuth position system with PID control in z-transfer functions.](image)

We conducted the experiments by loading the PID controller application and the antenna azimuth position system simulation to an ATmega128 microcontroller on a STK501 development board. We used the AVR studio and JTAGICE Mk II development tools supplied by Atmel Corporation. The output of the PID controller is sent to the input of the simulated antenna azimuth position system on the STK501 development board. The STK501 was connected through an RS232 serial interface to a PC, which runs terminal emulation software to capture the system output and store the data in a text file.

### 4.3 Input and Output Parameters of PID Control System

The inputs and outputs to the system that were used to control and evaluate the system are summarized in Table 1.

#### 4.3.1 Inputs

- The set point \( x \) is the reference input of the system.
- The system status \( y \) is the (simulated) output of the system position sensor, which acts as feedback to compare with the set point in the control system.
- The proportional parameter \( K_p \), also known as the gain, controls the proportional response by the control system to the error signal as described in Section 3.
- The integral parameter \( K_i \) is sometimes called integral gain, controls the contribution of the integral term to the overall control response, as described in Section 3.
- The derivative parameter \( K_d \) is sometimes called derivative gain which determines the magnitude of contribution of the derivative term to the overall control action.
- The sampling period \( T \) is the time period the digital system samples the analog signal input.

#### 4.3.2 Outputs

- The settling time \( t_s \) is the time for the transient’s damped oscillations to reach ±2% of the steady-state value.

<table>
<thead>
<tr>
<th>Inputs</th>
<th>Outputs</th>
</tr>
</thead>
<tbody>
<tr>
<td>Set point ( x )</td>
<td>Settling time ( t_s )</td>
</tr>
<tr>
<td>System status ( y )</td>
<td>Peak time ( t_p )</td>
</tr>
<tr>
<td>Proportional parameter ( K_p )</td>
<td>Rise time ( t_r )</td>
</tr>
<tr>
<td>Integral parameter ( K_i )</td>
<td>Percentage overshoot ( os )</td>
</tr>
<tr>
<td>Derivative parameter ( K_d )</td>
<td>Steady state error ( ess )</td>
</tr>
<tr>
<td>Sampling period ( T )</td>
<td></td>
</tr>
</tbody>
</table>

- The peak time \( t_p \) is the time required to reach the first or maximum peak.
- The rise time \( t_r \) is the time required for the waveform to go from 0.1 of the final value to 0.9 of the final value.
- The percentage overshoot \( os \) is the amount that the waveform overshoots the steady-state, or final value, at the peak time, expressed as percentage of the final value. \( ess \) is the system output error when the system is in steady state. It is used to measure the accuracy of the control system.

### 4.4 Metamorphic Relations for Testing of PID Controllers

We have identified four MRs for testing the PID controller from the properties of the PID control stated in Section 3.

In this section, we present an explanation of our metamorphic relations. In some cases, the full mathematical justifications for our metamorphic relations are quite complex, and are thus presented in the Appendix.
In the following, subscripted variables indicate whether the parameter refers to the source test case or follow-up test case. For instance, \( tr_1 \) refers to the rise time output for the source test case, and \( tr_2 \) refers to the rise time for the follow-up test case.

### Metamorphic Relation 1

It is obvious that the larger the difference between set point and system status the longer the settling time is needed. Based on this property, we can identify a metamorphic relation denoted MR1 as follows:

**MR1:**

\[
\text{If } (x_1 - y_1) < (x_2 - y_2) \text{ then } ts_1 < ts_2,
\]

### Metamorphic Relation 2

For a pure P controller — that is, one where \( K_i = 0 \) and \( K_d = 0 \) — if the proportional coefficient \( K_p \) increases, the rise time \( tr \) will decrease. Furthermore, the maximum overshoot will increase, and the steady-state error will decrease (see the Appendix for a full mathematical analysis of these propositions). Hence, we define MR2 as follows:

**MR2:**

\[
\text{If } (K_{p1} < K_{p2}) \land (K_{i1} = K_{i2} = 0) \land (K_{d1} = K_{d2} = 0) \text{ then } (tr_1 \geq tr_2) \land (os_1 < os_2) \land (ess_1 \geq ess_2)
\]

### Metamorphic Relation 3

Increasing the integral term has the effect of reducing the steady-state error (see the Appendix for a full explanation). However, it can also cause the present value to overshoot the set point value and slow the settling time, since the integral term responds to the accumulated error from the past. MR3 is therefore defined as follows:

**MR3:**

\[
\text{If } K_{i1} < K_{i2} \text{ then } (os_1 < os_2) \land (ess_1 \geq ess_2) \land (ts_1 \leq ts_2)
\]

<table>
<thead>
<tr>
<th>Input Parameters</th>
<th>Range for Original Test Cases</th>
<th>Range for Follow-up Test Cases</th>
</tr>
</thead>
<tbody>
<tr>
<td>Set point, ( X(z) )</td>
<td>[1, 8]</td>
<td>[2, 10]</td>
</tr>
<tr>
<td>Proportional gain, ( K_p )</td>
<td>[1, 8]</td>
<td>[2, 10]</td>
</tr>
<tr>
<td>Integral constant, ( K_i )</td>
<td>[0.001, 0.006]</td>
<td>[0.002, 0.01]</td>
</tr>
<tr>
<td>Derivative constant, ( K_d )</td>
<td>[0, 8]</td>
<td>[0.5, 10]</td>
</tr>
</tbody>
</table>

### Metamorphic Relation 4

Since \( \frac{d}{dt}e(t) \) represents the slope of \( e(t) \), the derivative control is essentially an anticipatory type of control. Normally, in a linear system, if the slope of \( e(t) \) due to a step input is large, a high overshoot will subsequently occur. The derivative control measures the instantaneous slope of \( e(t) \), predicts the overshoot ahead of time, and makes a proper correcting effort before the overshoot actually occurs. As a result, the increase of \( K_d \) will reduce the overshoot. It is apparent that the derivative control will affect the steady-state error of a system only if the steady state error varies with time. If the steady-state error of a system is constant with respect to time, the time derivative of this error is zero, and the derivative control has no effect on the steady-state error. If \( K_d \) is increased, the steady-state error will decrease or remain the same. As the increase of \( K_d \) will decrease the overshoot, the settling time will be decreased with the increase of \( K_d \). We can therefore define MR4 as follows:

**MR4:**

\[
\text{If } K_{d1} < K_{d2} \text{ then } (ts_1 \geq ts_2) \land (os_1 \geq os_2) \land (ess_1 \geq ess_2)
\]

### 4.5 Testing Procedures

We tested the embedded software of PID controller using a typical position control application for antenna. As mentioned in Section 4.2, we used a simulated antenna azimuth position system instead of a real antenna system. We then modeled the transfer function of the real antenna system as indicated in Fig. 4 with the z-transfer function as indicated in Fig. 5 and then implemented it using a difference equation in C on the embedded platform. The difference equation of the antenna azimuth position system is

\[
y(n) = 0.0006612x(n) + 1.9983y(n-1) - 0.9983y(n-2)
\]

where \( n \) is the discrete step at time \( t \) with a sampling period of \( T \).

We then used the AVR studio and JTAGICE Mk II to load the PID controller application and the antenna azimuth position system simulation into the flash memory of ATmega128 microcontroller on a STK501 development board. The output of the PID controller is sent as the input of the simulated antenna azimuth position system in the STK501 development board. The output of the antenna system is captured by a terminal application running on a PC connected to the STK501 board through the serial
Table 3: Mutants of PID Controller.

<table>
<thead>
<tr>
<th>Mutant</th>
<th>Modified line #</th>
<th>Fault description</th>
</tr>
</thead>
<tbody>
<tr>
<td>Mu1</td>
<td>103</td>
<td>Replacement of + by – in pid.c</td>
</tr>
<tr>
<td>Mu2</td>
<td>95</td>
<td>Replacement of pid_st-&gt;sumError by error in pid.c</td>
</tr>
<tr>
<td>Mu3</td>
<td>80</td>
<td>Replacement of * by + in pid.c</td>
</tr>
<tr>
<td>Mu4</td>
<td>103</td>
<td>Replacement of + by * in pid.c</td>
</tr>
<tr>
<td>Mu5</td>
<td>99</td>
<td>Replacement of - by / in pid.c</td>
</tr>
<tr>
<td>Mu6</td>
<td>94</td>
<td>Replacement of + by * in pid.c</td>
</tr>
<tr>
<td>Mu7</td>
<td>103</td>
<td>Replacement of i_term by p_term</td>
</tr>
<tr>
<td>Mu8</td>
<td>103</td>
<td>Replacement of p_term by i_term</td>
</tr>
</tbody>
</table>

Table 4: Proportion of Test Cases That Killed Mutants Using Metamorphic Relations.

<table>
<thead>
<tr>
<th></th>
<th>MR1</th>
<th>MR2</th>
<th>MR3</th>
<th>MR4</th>
</tr>
</thead>
<tbody>
<tr>
<td>Original</td>
<td>0%</td>
<td>0%</td>
<td>0%</td>
<td>0%</td>
</tr>
<tr>
<td>Mutant 1</td>
<td>0%</td>
<td>0%</td>
<td>1%</td>
<td>100%</td>
</tr>
<tr>
<td>Mutant 2</td>
<td>0%</td>
<td>0%</td>
<td>37%</td>
<td>0%</td>
</tr>
<tr>
<td>Mutant 3</td>
<td>99%</td>
<td>0%</td>
<td>40%</td>
<td>42%</td>
</tr>
<tr>
<td>Mutant 4</td>
<td>98%</td>
<td>0%</td>
<td>100%</td>
<td>0%</td>
</tr>
<tr>
<td>Mutant 5</td>
<td>95%</td>
<td>0%</td>
<td>1%</td>
<td>100%</td>
</tr>
<tr>
<td>Mutant 6</td>
<td>0%</td>
<td>0%</td>
<td>100%</td>
<td>0%</td>
</tr>
<tr>
<td>Mutant 7</td>
<td>0%</td>
<td>0%</td>
<td>100%</td>
<td>0%</td>
</tr>
<tr>
<td>Mutant 8</td>
<td>17%</td>
<td>100%</td>
<td>100%</td>
<td>0%</td>
</tr>
</tbody>
</table>

As mentioned in Section 3, the selection of the ranges of set point \( x \), \( K_p \), \( K_i \) and \( K_d \) were chosen to ensure that the resulting system is stable. We performed a number of simulations of the control system as shown in Fig. 5 to define the range of input parameters as listed in Table 2 for stable operation. These ranges were used to determine bounds for the generation of input parameters. As the sampling interval \( T \) is not present in our metamorphic relations, and its effects on computation can also be achieved by varying the gain constants, it was set as a constant at 10 milliseconds for all test cases. Similarly, as the behavior of the PID controller depends on the difference between the Set point and the initial system status (\( y \)), for simplicity \( y \) was set at 0 for all test cases.

100 source test cases were generated by uniform random sampling within the input ranges as specified in Table 2. For each source test case, four follow-up test cases were generated, one for each of the MRs. To generate a follow-up test case, a random sample for the varying parameter (for instance, for MR1, the initial set point \( X(z) \)) was generated from the ranges for the follow-up test cases defined in Table 2. If the resulting test case met the MR condition (for instance, that \( X(z) \) was increased), the follow-up test case input was accepted, otherwise the process was repeated until an eligible follow-up test case was located.

We initially ran the test cases on the unmodified source code to determine if there were any pre-existing faults in it – while this was considered unlikely, it avoided the possibility of such pre-existing faults interfering with measurement of the effectiveness in mutant detection. As no fault was detected in the original software, we went on to generate 8 mutant versions of the software to evaluate the failure-detection performance of metamorphic testing.

4.6 Mutants

Mutants were generated by transforming the original code to a mutated code using randomly selected mutation operator. The program line to mutate is randomly selected using random number generator. If the mutation operator cannot be applied for the selected line, we will search the program lines closest to it. Table 3 shows the mutant versions of the PID controller.

4.7 Results

Table 4 shows the proportion of source/follow-up test case pairs which revealed a violation of the metamorphic relation (and thus revealed a bug and “killed the mutant”) for the unmodified source code, and the eight mutants.

All the mutant versions of the PID controller were killed by at least one of the MRs with the test
cases available. Mutant 1 violates MR3 and MR4 when tested with 1% and 100% of the test case pairs, respectively. It is reasonable because the fault of Mutant 1 is in the sign of derivative term. It therefore causes a violation of MR4 with 100% of the generated test cases. Mutant 2’s fault is due to a single error value instead of the sum of errors in the integral term. This fault effectively results in the PID controller acting as a PD controller, causing a 37% failure rate in the testing associated with MR3. The proportional gain is added to the error instead of multiplied by the error in Mutant 3. It does not affect the direction of effect of proportional parameter, as the proportional term still increases if the proportional parameter is increased, and as such MR2 does not detect the error. Since this mistake turns the PID controller to another unknown type of controller, it does not satisfy the relations of MR1, MR3 and MR4 which hence reveal the error. Mutant 4 has the integral term and derivative term to be incorrectly multiplied together, instead of added. Mutant 4 is therefore no longer a PID controller, and so MR1 and MR4 are violated with most test case pairs. As MR2 relates to the change of $K_p$, which is unaffected by this seeded fault, and the integral term of dominates the effect of derivative term, MR2 and MR4 cannot detect the fault. Mutant 5 relates to a fault in the derivative term, so it is understandable that there is a violation of MR4 in 100% of test case pairs. Since MR1 relates to all the parameters, it is also affected. MR3 is a summation of all sampled errors, so it is violated in some test cases. Mutant 6 and Mutant 7 change the integral term calculation, so MR3 is violated in 100% of cases. The fault in Mutant 8 is the replacement of the proportional gain by the integral parameter. It is therefore understandable that MR2 and MR3 are violated in 100% of the test case pairs.

5 THREATS TO VALIDITY

5.1 Internal Validity

The only major threats to the internal validity of this study are incorrect implementation of the code simulating the antenna motor and sensor, and the various pieces of experimental scaffolding used to generate test cases and collect results. The motor simulation required very few lines of code, and was tested to ensure that it reflected the expected behavior. The experimental scaffolds are also very simple. The PID controller itself was, as noted, sample code and not implemented by the authors.

5.2 External Validity

The “bugs” detected by the metamorphic relations were mutations deliberately seeded into the controller code. While at least one study suggests a connection between the failure behavior of mutants and “real” bugs (Daran & Th’evenod-Fosse (1996)) we cannot be certain such a connection generalizes to controller software.

While the metamorphic relations demonstrated here should be applicable to most applications in which a PID controller is used, it is uncertain how they will perform in revealing actual bugs in real systems. It is also uncertain whether effective metamorphic testing can be achieved on other types of controllers. While the extensive mathematics underpinning control theory should make it relatively straightforward to derive metamorphic relations for other types of controllers, further studies will be required to demonstrate efficacy.

6 CONCLUSIONS

Software-based control systems in general, and PID controllers in particular, are widely deployed technologies. It is therefore crucial that they are demonstrated to be reliable before deployment. However, they can be difficult to test effectively as verifying the outputs is subject to the oracle problem. We have demonstrated the ability to effectively kill mutants in a PID controller using metamorphic testing; all eight mutants tested were killed by at least one metamorphic relation.

A key question for the industrial application of metamorphic testing is the ease with which effective MRs can be found. In the case of the PID controller, control theory made it relatively straightforward for a domain expert to find suitable MRs. This is consistent with studies in other problem domains, where suitable MRs have been reasonably readily identified.

However, it is worth considering the relative effectiveness of the four metamorphic relations. The most effective was MR3, which relates to the integral term. It was able to kill all eight mutants. As the integral term consists of the summation of the entire error signal (and thus the behavior of the controller over the entire time scale), it makes sense that it revealed more mutants than other MRs. By contrast, MR2, which relates to the proportional term and thus depends only on the instantaneous error, revealed only one mutant. To maximize the effectiveness of metamorphic testing, it would obviously be desirable
to have some way to identify MRs that are more likely to find faults.

Our study concentrated entirely on the testing of the controller software, and simulated “perfect” hardware. In practice, hardware may of course have faults. Metamorphic testing could be used to test the complete system, including hardware. However, it is not clear whether the metamorphic relations used here are useful in detecting hardware faults – and, if the present MRs are unsuitable, whether there are others that can provide useful fault-finding capabilities beyond existing techniques. This is clearly an area worthy of future study.

We believe that our study provides good evidence of the promise of metamorphic testing in control applications. However, there are more advanced control systems that control higher order attributes (for instance, in a mechanical system, speed and acceleration). We propose to conduct further studies to demonstrate that these, too, can be effectively tested without an oracle using metamorphic testing techniques.

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REFERENCES


APPENDIX: DERIVATION OF SOME METAMORPHIC RELATIONS

In this appendix, we follow the notation used in Table 1.

Metamorphic Relation 1

Consider a P controller (that is, a PID controller where the integral and derivative parameters are 0) controlling a second order plant as shown in Fig. 6, the closed loop transfer function will be

$$ Y(s) = \frac{K_p b}{s^2 + as + K_p b} $$

(3)

For any second order control system with the general closed loop transfer function of

$$ Y(s) = \frac{\omega_n^2}{s^2 + 2\xi \omega_n s + \omega_n^2} $$

(4)

Figure 6: General P control system.

The rise time $t_r$ can be obtained by the following approximation:

$$ t_r \equiv \frac{0.8 + 2.5\xi}{\omega_n} $$

From equations (3) and (4), we have

$$ t_r \equiv \frac{0.8 + 2.5\alpha/\sqrt{K_p b}}{\sqrt{K_p b}} $$

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Increasing $K_p$ will decrease the rise time $t_r$. For any second order control system, the maximum overshoot can be obtained as:

$$\max os = 100 \times e^{\frac{-\pi^2}{4n^2}}$$

From equations (3) and (4), we obtain

$$\text{maximum } os = 100 \times e^{\frac{-na}{2K_p}} \sqrt{K_p a^2}$$

When $K_p$ increases, maximum overshoot increases. From Fig. 6, for step input with the error $e(s) = \frac{s+a}{aK_p}$, the steady state error can be obtained as follows:

$$e(\infty) = \lim_{s \to 0} \frac{s+a}{aK_p} = \frac{1}{K_p}$$

When $K_p$ increases, the steady state error decreases. Therefore, we have:

**MR2:**

If $(K_p1 < K_p2) \land (K_d1 = K_d2 = 0) \land (K_i1 = K_i2 = 0)$ then $(t_s1 \geq t_s2) \land (os1 < os2) \land (ess1 \geq ess2)$

**Metamorphic Relation 2**

The integral term added to the proportional term is equivalent to adding a zero at $s = -K_i/K_p$ and a pole at $s = 0$ to the open loop transfer function.

The transfer function will be

$$Y(s) = \frac{b(s+K_p)}{s^2(s+a)+b(s+K_p/K_i)}X(s)$$

Then

$$E(s) = \frac{s^2(s+a)}{s^2(s+a)+b(s+K_p/K_i)}X(s)$$

For a step input with magnitude $X$, the steady state error is:

$$e(\infty) = \lim_{s \to 0} \frac{s^2(s+a)}{s^2(s+a)+b(s+K_p/K_i)}X = \frac{K_i}{K_p} \cdot \frac{X}{b}$$

Since $K_i < 1$, it will then reduce the steady state error. Since the integral term is responding to accumulated errors from the past, it can cause the present value to overshoot the set point value and slow the settling time. MR3 is therefore defined as follows:

**MR3:**

If $K_i1 < K_i2$ then

$(os1 < os2) \land (ess1 \geq ess2) \land (ts1 \leq ts2)$

**Metamorphic Relation 3**

Since $de(t)/dt$ represents the slope of $e(t)$, the derivative control is essentially an anticipatory type of control. Normally, in a linear system, if the slope of $e(t)$ is large due to a step input, a high overshoot will subsequently occur. The derivative control measures the instantaneous slope of $e(t)$, predicts the large overshoot ahead of time, and makes a proper correcting effort before the overshoot actually occurs. As a result, the increase of $K_d$ will reduce the overshoot. It is apparent that the derivative control will affect the steady-state error of a system only if the steady state error varies with time. If the steady-state error of a system is constant with respect to time, the time derivative of this error is zero, and the derivative control has no effect on the steady-state error. The increase of $K_d$ will not increase the steady state error. As the increase of $K_d$ will decrease the overshoot, the settling time will be decreased with the increase of $K_d$. We can therefore define MR4 as follows:

**MR4:**

If $K_d1 < K_d2$ then

$(ts1 \geq ts2) \land (os1 \geq os2) \land (ess1 \geq ess2)$